LM160/LM360 High Speed Differential Comparator

Check for Samples: LM160, LM360

FEATURES
- Ensured high speed: 20 ns max
- Tight delay matching on both outputs
- Complementary TTL outputs
- High input impedance
- Low speed variation with overdrive variation
- Fan-out of 4
- Low input offset voltage
- Series 74 TTL compatible

DESCRIPTION
The LM160/LM360 is a very high speed differential input, complementary TTL output voltage comparator with improved characteristics over the μA760/μA760C, for which it is a pin-for-pin replacement. The device has been optimized for greater speed, input impedance and fan-out, and lower input offset voltage. Typically delay varies only 3 ns for overdrive variations of 5 mV to 400 mV.

Complementary outputs having minimum skew are provided. Applications involve high speed analog to digital convertors and zero-crossing detectors in disk file systems.

CONNECTION DIAGRAMS

Figure 1. Package Number LMC0008C (1)

Figure 2. Package Number D0008A or P0008E

(1) Also available in SMD# 5962-8767401

These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

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### Absolute Maximum Ratings

<table>
<thead>
<tr>
<th>Parameter</th>
<th>LM160</th>
<th>LM360</th>
</tr>
</thead>
<tbody>
<tr>
<td>Positive Supply Voltage</td>
<td>+8V</td>
<td>−8V</td>
</tr>
<tr>
<td>Negative Supply Voltage</td>
<td>−8V</td>
<td>+8V</td>
</tr>
<tr>
<td>Peak Output Current</td>
<td>20 mA</td>
<td></td>
</tr>
<tr>
<td>Differential Input Voltage</td>
<td>±5V</td>
<td></td>
</tr>
<tr>
<td>Input Voltage</td>
<td>$V^+ \geq V_{IN} \geq V^-$</td>
<td></td>
</tr>
<tr>
<td>ESD Tolerance (3)</td>
<td>1600V</td>
<td></td>
</tr>
<tr>
<td>Operating Temperature Range</td>
<td>LM160 −55°C to +125°C</td>
<td>LM360 0°C to +70°C</td>
</tr>
<tr>
<td>Storage Temperature Range</td>
<td>−65°C to +150°C</td>
<td></td>
</tr>
<tr>
<td>Lead Temperature (Soldering, 10 sec.)</td>
<td>260°C</td>
<td></td>
</tr>
</tbody>
</table>

#### Soldering Information

<table>
<thead>
<tr>
<th>Package Type</th>
<th>Soldering Method</th>
<th>Temperature</th>
</tr>
</thead>
<tbody>
<tr>
<td>PDIP Package</td>
<td>Soldering (10 seconds)</td>
<td>260°C</td>
</tr>
<tr>
<td>SOIC Package</td>
<td>Vapor Phase (60 seconds)</td>
<td>215°C</td>
</tr>
<tr>
<td></td>
<td>Infrared (15 seconds)</td>
<td>220°C</td>
</tr>
</tbody>
</table>

See AN-450 “Surface Mounting Methods and Their Effect on Product Reliability” for other methods of soldering surface mount devices.

(1) The device may be damaged if used beyond the maximum ratings.
(3) Human body model, 1.5 kΩ in series with 100 pF.
## Electrical Characteristics

\((T_{\text{MIN}} \leq T_A \leq T_{\text{MAX}})\)

<table>
<thead>
<tr>
<th>Parameter</th>
<th>Conditions</th>
<th>Min</th>
<th>Typ</th>
<th>Max</th>
<th>Units</th>
</tr>
</thead>
<tbody>
<tr>
<td>Operating Conditions</td>
<td></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>Supply Voltage (V_{\text{CC}^+})</td>
<td></td>
<td>4.5</td>
<td>5</td>
<td>6.5</td>
<td>V</td>
</tr>
<tr>
<td>Supply Voltage (V_{\text{CC}^-})</td>
<td></td>
<td>-4.5</td>
<td>-5</td>
<td>-6.5</td>
<td>V</td>
</tr>
<tr>
<td>Input Offset Voltage</td>
<td>(R_S \leq 200\Omega)</td>
<td>2</td>
<td>5</td>
<td>mV</td>
<td></td>
</tr>
<tr>
<td>Input Offset Current</td>
<td></td>
<td>0.5</td>
<td>3</td>
<td>(\mu)A</td>
<td></td>
</tr>
<tr>
<td>Input Bias Current</td>
<td></td>
<td>5</td>
<td>20</td>
<td>(\mu)A</td>
<td></td>
</tr>
<tr>
<td>Output Resistance (Either Output)</td>
<td>(V_{\text{OUT}} = V_{\text{OH}})</td>
<td>100</td>
<td></td>
<td>(\Omega)</td>
<td></td>
</tr>
<tr>
<td>Response Time</td>
<td>(T_A = 25^\circ\text{C}, V_S = \pm 5\text{V}) (1) (2)</td>
<td>13</td>
<td>25</td>
<td>ns</td>
<td></td>
</tr>
<tr>
<td>Response Time</td>
<td>(T_A = 25^\circ\text{C}, V_S = \pm 5\text{V}) (3) (2)</td>
<td>12</td>
<td>20</td>
<td>ns</td>
<td></td>
</tr>
<tr>
<td>Response Time Difference between Outputs</td>
<td>(T_A = 25^\circ\text{C}) (1) (2)</td>
<td>2</td>
<td></td>
<td>ns</td>
<td></td>
</tr>
<tr>
<td>Input Resistance</td>
<td>(f = 1\text{MHz})</td>
<td>17</td>
<td></td>
<td>k(\Omega)</td>
<td></td>
</tr>
<tr>
<td>Input Capacitance</td>
<td>(f = 1\text{MHz})</td>
<td>3</td>
<td></td>
<td>pF</td>
<td></td>
</tr>
<tr>
<td>Average Temperature Coefficient of Input Offset Voltage</td>
<td>(R_S = 50\Omega)</td>
<td>8</td>
<td></td>
<td>(\mu)V/(^\circ\text{C})</td>
<td></td>
</tr>
<tr>
<td>Average Temperature Coefficient of Input Offset Current</td>
<td></td>
<td>7</td>
<td></td>
<td>nA/(^\circ\text{C})</td>
<td></td>
</tr>
<tr>
<td>Common Mode Input Voltage Range</td>
<td>(V_S = \pm 6.5\text{V})</td>
<td>±4</td>
<td>±4.5</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>Differential Input Voltage Range</td>
<td></td>
<td>±5</td>
<td></td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>Output High Voltage (Either Output)</td>
<td>(I_{\text{OUT}} = \sim 320\ \mu\text{A}, V_S = \pm 4.5\text{V})</td>
<td>2.4</td>
<td>3</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>Output Low Voltage (Either Output)</td>
<td>(I_{\text{SINK}} = 6.4\ mA)</td>
<td>0.25</td>
<td>0.4</td>
<td>V</td>
<td></td>
</tr>
<tr>
<td>Positive Supply Current</td>
<td>(V_S = \pm 6.5\text{V})</td>
<td>18</td>
<td>32</td>
<td>mA</td>
<td></td>
</tr>
<tr>
<td>Negative Supply Current</td>
<td>(V_S = \pm 6.5\text{V})</td>
<td>-9</td>
<td>-16</td>
<td>mA</td>
<td></td>
</tr>
</tbody>
</table>

1. Response time measured from the 50% point of a 30 mVp-p 10 MHz sinusoidal input to the 50% point of the output.
2. Measurements are made in AC Test Circuit, Fanout = 1
3. Response time measured from the 50% point of a 2 Vp-p 10 MHz sinusoidal input to the 50% point of the output.
4. Response time measured from the start of a 100 mV input step with 5 mV overdrive to the time when the output crosses the logic threshold.
Typical Performance Characteristics

Offset Voltage

V^+ = +5V
V^- = -5V

Input Current vs Ambient Temperature

Supply Current vs Ambient Temperature

Input Characteristics

V^+ = +5V
V^- = -5V

Delay of Output 1 With Respect to Output 2 vs Ambient Temperature

Propagation Delay vs Ambient Temperature

See AC Test Circuit – Both Outputs Loaded

FANOUT = 4

FANOUT = 1

See AC Test Circuit – FANOUT = 4

FANOUT = 1

FANOUT = 4

-55 to -15 to 5 to 25 to 65 to 85 to 105 to 125

AMBIENT TEMPERATURE (°C)

-5 to -4 to -3 to -2 to -1 to 0 to 1 to 2 to 3 to 4 to 5

DIFFERENTIAL INPUT VOLTAGE (V)

4

2

0

-55 to -15 to 5 to 25 to 65 to 85 to 105 to 125

AMBIENT TEMPERATURE (°C)

4

2

0

-55 to -15 to 5 to 25 to 65 to 85 to 105 to 125

AMBIENT TEMPERATURE (°C)

4

2

0

-55 to -15 to 5 to 25 to 65 to 85 to 105 to 125

AMBIENT TEMPERATURE (°C)
Typical Performance Characteristics (continued)

Common-Mode Pulse Response

OUTPUT VOLTAGE (mV) vs. INPUT VOLTAGE (V)

TIME (ns)

0  40  80  120  160

0   0.5   1   1.5   2   2.5   3

130  140  150

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Product Folder Links: LM160 LM360
AC TEST CIRCUIT

\( V_{IN} = \pm 50 \text{ mV} \)
\( FANOUT=1 \quad FANOUT=4 \)
\( V^+ = +5\text{V} \quad R=2.4k \quad R=630\Omega \)
\( V^- = -5\text{V} \quad C=15\text{ pF} \quad C=30\text{ pF} \)
**REVISION HISTORY**

Changes from Revision B (March 2013) to Revision C | Page
---|---
- Changed layout of National Data Sheet to TI format | 7
## PACKAGING INFORMATION

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<th>Orderable Device</th>
<th>Status</th>
<th>Package Type</th>
<th>Package Drawing</th>
<th>Pins</th>
<th>Package Qty</th>
<th>Eco Plan</th>
<th>Lead/Ball Finish</th>
<th>MSL Peak Temp</th>
<th>Op Temp (°C)</th>
<th>Device Marking</th>
<th>Samples</th>
</tr>
</thead>
<tbody>
<tr>
<td>LM360M</td>
<td>ACTIVE</td>
<td>SOIC</td>
<td>D</td>
<td>8</td>
<td>95</td>
<td>TBD</td>
<td>Call TI</td>
<td>Call TI</td>
<td>0 to 70</td>
<td>LM 360M</td>
<td></td>
</tr>
<tr>
<td>LM360M/NOPB</td>
<td>ACTIVE</td>
<td>SOIC</td>
<td>D</td>
<td>8</td>
<td>95</td>
<td>Green (RoHS &amp; no Sb/Br)</td>
<td>CU SN</td>
<td>Level-1-260C-UNLIM</td>
<td>0 to 70</td>
<td>LM 360M</td>
<td></td>
</tr>
<tr>
<td>LM360MX</td>
<td>ACTIVE</td>
<td>SOIC</td>
<td>D</td>
<td>8</td>
<td>2500</td>
<td>TBD</td>
<td>Call TI</td>
<td>Call TI</td>
<td>0 to 70</td>
<td>LM 360M</td>
<td></td>
</tr>
<tr>
<td>LM360MX/NOPB</td>
<td>ACTIVE</td>
<td>SOIC</td>
<td>D</td>
<td>8</td>
<td>2500</td>
<td>Green (RoHS &amp; no Sb/Br)</td>
<td>CU SN</td>
<td>Level-1-260C-UNLIM</td>
<td>0 to 70</td>
<td>LM 360M</td>
<td></td>
</tr>
</tbody>
</table>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) **MSL, Peak Temp.:** The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) **Lead/Ball Finish:** Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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TAPE AND REEL INFORMATION

<table>
<thead>
<tr>
<th>Device</th>
<th>Package Type</th>
<th>Package Drawing</th>
<th>Pins</th>
<th>SPQ</th>
<th>Reel Diameter (mm)</th>
<th>Reel Width W1 (mm)</th>
<th>A0 (mm)</th>
<th>B0 (mm)</th>
<th>K0 (mm)</th>
<th>P1 (mm)</th>
<th>W (mm)</th>
<th>Pin1 Quadrant</th>
</tr>
</thead>
<tbody>
<tr>
<td>LM360MX</td>
<td>SOIC</td>
<td>D</td>
<td>8</td>
<td>2500</td>
<td>330.0</td>
<td>12.4</td>
<td>6.5</td>
<td>5.4</td>
<td>2.0</td>
<td>8.0</td>
<td>12.0</td>
<td>Q1</td>
</tr>
<tr>
<td>LM360MX/NOPB</td>
<td>SOIC</td>
<td>D</td>
<td>8</td>
<td>2500</td>
<td>330.0</td>
<td>12.4</td>
<td>6.5</td>
<td>5.4</td>
<td>2.0</td>
<td>8.0</td>
<td>12.0</td>
<td>Q1</td>
</tr>
</tbody>
</table>

*All dimensions are nominal*
**TAPE AND REEL BOX DIMENSIONS**

*All dimensions are nominal*

<table>
<thead>
<tr>
<th>Device</th>
<th>Package Type</th>
<th>Package Drawing</th>
<th>Pins</th>
<th>SPQ</th>
<th>Length (mm)</th>
<th>Width (mm)</th>
<th>Height (mm)</th>
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</thead>
<tbody>
<tr>
<td>LM360MX</td>
<td>SOIC</td>
<td>D</td>
<td>8</td>
<td>2500</td>
<td>367.0</td>
<td>367.0</td>
<td>35.0</td>
</tr>
<tr>
<td>LM360MX/NOPB</td>
<td>SOIC</td>
<td>D</td>
<td>8</td>
<td>2500</td>
<td>367.0</td>
<td>367.0</td>
<td>35.0</td>
</tr>
</tbody>
</table>
NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

9. Board assembly site may have different recommendations for stencil design.
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